

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	6686	(hotelling or "t.sup.2" or distance near model or dmodx)	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:02
S2	7490	residual near error	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:02
S3	2183919	(wafer or semiconductor)	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:06
S4	24	S1 and S2 and S3	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:06
S5	6920	(hotelling or "t.sup.2" or distance near model or dmodx or tsquare)	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:25
S6	113	S3 same S5	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:26
S7	86	S3 same S5 and @AD < "20030517"	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:27
S8	333	(438/9).ccls.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:57

S9	2748	(438/14).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:57
S10	217564	("438"/\$).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:57
S11	628	(257/E21.528).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:57
S12	422718	("257"/\$).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:58
S13	5458	Yue.inv.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:58
S14	196904	Tokyo.asn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 20:59
S15	2	S8 and S7	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:08
S16	0	S9 and S7	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:08
S17	6	S10 and S7	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:08

S18	1	S11 and S7	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:08
S19	26	S12 and S7	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:08
S20	3	S14 and S6	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:10
S21	24	S2 and S3 and S5	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:13
S22	1	S13 and S21	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:14
S23	4	S14 and S21	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:14
S24	805	S3 and S5 and @AD < "20030517"	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:16
S25	62275	(principal near component or pca)	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:17
S26	30	S24 and S25	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:17

S27	1878	(257/E21.525).ccls.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:23
S28	5	S27 and S7	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:23
S29	12	S27 and S26	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/06/19 21:24
S30	3	("6442496").PN.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/19 21:26
S31	105	principal adj component and compar\$4 with control with statistic\$4	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 08:51
S32	44	statistic\$4 with principal adj component and compar\$4 with control with statistic\$4	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 08:51
S33	21	statistic\$4 with (principal adj component or pca) and compar\$4 with control with statistic\$4 and metrology	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:16
S35	2	(multivaria\$6 near statistic\$4 or principal adj component or pca) and compar\$4 with control with statistic\$4 and metrology and @AD < "20030517"	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:21

S36	27	(multivaria\$6 near statistic\$4 or principal adj component or pca) and compar\$4 with (control or limit) and metrology and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:22
S37	2	(principal adj component or pca) same compar\$4 with (control or limit) and metrology and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:33
S38	24	(principal adj component or pca) and compar\$4 with (control or limit) and metrology and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:34
S39	586	(principal adj component or pca) and compar\$4 with (control or limit) and semiconductor and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:35
S40	42	(principal adj component or pca) same compar\$4 with (control or limit) and semiconductor and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:35
S41	2	((principal adj component or pca) same compar\$4 with (control or limit) and semiconductor).clm. and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:35
S42	6	((principal adj component or pca) and compar\$4 with (control or limit) and semiconductor).clm. and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:37
S43	2816	(438/14).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S44	13	S43 and S39	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40

S45	225210	("438"/\$).ccls.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S46	39	S45 and S39	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S47	684	(257/E21.528).ccls.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S48	9	S47 and S39	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S49	438591	("257"/\$).ccls.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S50	61	S49 and S39	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S51	6069	Yue.inv.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S52	5	S51 and S39	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S53	200564	Tokyo.asn.	US_PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40

S54	6	S53 and S39	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:40
S55	68	(principal adj component or pca) with (calculat\$4 or project\$4 or predict \$4) and compar\$4 with (control or limit) and semiconductor and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/21 09:58
S56	2	("5831446").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/11/21 11:55
S57	2	("6291254").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/11/21 11:56
S58	2	("4231809").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/11/21 11:58
S59	2	("20070207595").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/11/21 12:02
S60	2	("20060105475").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/11/21 12:02
S61	93	("4888199" "5014217" "5040734" "5114233" "5121337" "5172312" "5288367" "5308414" "5347460" "5442562" "5467883").PN. OR ("5658423").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/11/21 12:46

S62	68	(principal adj component or pca) with (calculat\$4 or project\$4 or predict \$4) and compar\$4 with (control or limit) and semiconductor and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/25 18:42
S63	7255	(hotelling or "t.sup.2" or distance near model or dmodx or tsquare)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/25 18:42
S64	9	S62 and S63	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/25 18:42
S65	1	((principal adj component or pca) with (calculat\$4 or project\$4 or predict\$4) and compar\$4 with (control or limit) and semiconductor).clm. and @AD < "20030517"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/11/25 18:59

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